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<sup>1</sup> Bell Telephone Laboratories, Inc.

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<sup>6</sup> M.I.T., Cambridge, Mass.

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<sup>1</sup> Bell Telephone Laboratories, Inc.

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<sup>1</sup> Bell Telephone Laboratories, Inc.

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<sup>3</sup> Southern Bell Telephone and Telegraph Company.

<sup>5</sup> Columbia University, New York City.

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<sup>1</sup> Bell Telephone Laboratories, Inc.